## GENERAL DESCRIPTION

The SGM7222 is a high-speed, low-power double-pole/ double-throw (DPDT) analog switch that operates from a single 1.8 V to 4.3 V power supply

SGM7222 is designed for the switching of high-speed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os

The SGM7222 has low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480 Mbps). Each switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. Its bandwidth is wide enough to pass high-speed USB 2.0 differential signals ( $480 \mathrm{Mb} / \mathrm{s}$ ) with good signal integrity.

The SGM7222 contains special circuitry on the D+/Dpins which allows the device to withstand a $V_{\text {BUS }}$ short to D+ or D- when the USB devices are either powered off or powered on.

SGM7222 is available in Green TQFN-1.8×1.4-10L, MSOP-10 and UTQFN-1.8×1.4-10L packages. It operates over an ambient temperature range of $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.

## APPLICATIONS

Route Signals for USB 2.0
MP3 and Other Personal Media Players
Digital Cameras and Camcorders
Portable Instrumentation
Set-Top Boxes
PDAs

## FEATURES

- $R_{\text {ON }}$ is Typically $4.5 \Omega$ at 3.0 V
- Low Bit-to-Bit Skew: 50ps (TYP)
- Voltage Operation: 1.8 V to 4.3 V
- Fast Switching Times:

$$
\begin{aligned}
& \mathrm{t}_{\mathrm{ON}} 10 \mathrm{~ns} \\
& \mathrm{t}_{\text {OFF }} 22 \mathrm{~ns}
\end{aligned}
$$

- Low Crosstalk: -41dB at 250MHz
- Power-Off Protection when $\mathrm{V}_{+}=0 \mathrm{~V}$,

D+/D- Pins can Tolerate up to 5.25 V

- High Off-Isolation: -35dB at 250MHz
- Rail-to-Rail Input and Output Operation
- Break-Before-Make Switching
- Extended Industrial Temperature Range:
$-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
- Small Packages:

MSOP-10, TQFN-1.8×1.4-10L and
UTQFN-1.8×1.4-10L

## BLOCK DIAGRAM



SG Micro Corp
REV. B. 2
www.sg-micro.com

## PACKAGE/ORDERING INFORMATION

| MODEL | PIN- <br> PACKAGE | SPECIFIED <br> TEMPERATURE <br> RANGE | ORDERING <br> NUMBER | PACKAGE <br> MARKING | PACKAGE <br> OPTION |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | MSOP-10 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SGM7222YMS10/TR | SGM7222YMS10 | Tape and Reel, 3000 |
|  | TQFN-1.8 $\times 1.4-10 \mathrm{~L}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SGM7222YWQ10/TR | 7222 | Tape and Reel, 3000 |
|  | UTQFN-1.8 $\times 1.4-10 \mathrm{~L}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SGM7222YUWQ10/TR | 7222 | Tape and Reel, 3000 |

## ABSOLUTE MAXIMUM RATINGS

$\qquad$ 0 V to 4.6 V
$V_{+}$to GND
Analog, Digital voltage range ........................-0.3V to ( $\mathrm{V}_{+}$) + 0.3 V
Continuous Current HSDn or Dn.................................... $\pm 100 \mathrm{~mA}$
Peak Current HSDn or Dn.............................................. $\pm 150 \mathrm{~mA}$
Operating Temperature Range........................... $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
Junction Temperature........................................................ $150^{\circ} \mathrm{C}$
Storage Temperature Range............................ $65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$
Lead Temperature (Soldering, 10s).................................... $260^{\circ} \mathrm{C}$
ESD Susceptibility
HBM. 8000V
$\qquad$

NOTE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## CAUTION

This integrated circuit can be damaged by ESD if you don't pay attention to ESD protection. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

SGMICRO reserves the right to make any change in circuit design, specification or other related things if necessary without notice at any time. Please contact SGMICRO sales office to get the latest datasheet.

PIN CONFIGURATIONS (TOP VIEW)


## PIN DESCRIPTION

| TQFN-1.8×1.4-10L/ <br> UTQFN-1.8×1.4-10L | MSOP-10 | NAME | FUNCTION |
| :---: | :---: | :---: | :--- |
| 9 | 10 | V $_{+}$ |  |
| 4 | 5 | GND | Ground |
| 10 | 1 | S | Select Input |
| 8 | 9 | Output Enable |  |
| 1,2 | 2,3 | HSD1+, HSD2+ |  |
| 7,6 | 8,7 | HSD1- , HSD2- |  |
| 3,5 | 4,6 | D+, D- |  |

## FUNCTION TABLE

| $\overline{\mathbf{O E}}$ | $\mathbf{S}$ | HSD1+ <br> HSD1- | HSD2+ <br> HSD2- |
| :---: | :---: | :---: | :---: |
| 0 | 0 | ON | OFF |
| 0 | 1 | OFF | ON |
| 1 | $\times$ | OFF | OFF |

NOTE: Switches Shown For Logic "0" Input

## ELECTRICAL CHARACTERISTICS

$\left(\mathrm{V}_{+}=+1.8 \mathrm{~V}\right.$ to $+4.3 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{IH}}=+1.6 \mathrm{~V}, \mathrm{~V}_{\mathrm{IL}}=+0.5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$. Typical values are at $\mathrm{V}_{+}=+3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | TEMP | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| Analog I/O Voltage (HSD1+, HSD1-, HSD2+, HSD2-) | $\mathrm{V}_{\text {Is }}$ |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 0 |  | $\mathrm{V}_{+}$ | V |
| On-Resistance | Ron | $\mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } 0.4 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=8 \mathrm{~mA} \text {, }$ <br> Test Circuit 1 | $+25^{\circ} \mathrm{C}$ |  | 4.5 | 8.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 9 |  |
| On-Resistance Match Between Channels | $\Delta \mathrm{R}_{\text {ON }}$ | $\mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } 0.4 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=8 \mathrm{~mA} \text {, }$ <br> Test Circuit 1 | $+25^{\circ} \mathrm{C}$ |  | 0.15 | 0.6 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1.6 |  |
| On-Resistance Flatness | $\mathrm{R}_{\text {flaton) }}$ | $\mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } 1.0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=8 \mathrm{~mA} \text {, }$ Test Circuit 1 | $+25^{\circ} \mathrm{C}$ |  | 1.5 | 2.0 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 2.6 |  |
| Power Off Leakage Current ( $\mathrm{D}+$, D-) | loff | $\begin{aligned} & \mathrm{V}_{+}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=0 \mathrm{~V} \text { to } 3.6 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{s}}, V_{\overline{O E}}=0 \mathrm{~V} \text { or } 3.6 \mathrm{~V} \\ & \hline \end{aligned}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |
| Increase in $I_{+}$per Control Voltage | $\mathrm{I}_{\text {cct }}$ | $\mathrm{V}_{+}=3.6 \mathrm{~V}, \mathrm{~V}_{\text {S }}$ or $\mathrm{V}_{\overline{\text { OE }}}=2.6 \mathrm{~V}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 5 | $\mu \mathrm{A}$ |
| Source Off Leakage Current | $\mathrm{I}_{\text {HSD2(OFF) }} \mathrm{I}_{\text {HSD1 }}$ (OFF) | $\begin{aligned} & \mathrm{V}_{+}=3.6 \mathrm{~V}, \mathrm{~V}_{1 \mathrm{~S}}=3.3 \mathrm{~V} / 0.3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{D}}=0.3 \mathrm{~V} / 3.3 \mathrm{~V} \end{aligned}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |
| Channel On Leakage Current | $\mathrm{I}_{\text {HSD2(ON), }} \mathrm{I}_{\text {HSD1(ON) }}$ | $\begin{aligned} & \mathrm{V}_{+}=3.6 \mathrm{~V}, \mathrm{~V}_{\text {IS }}=3.3 \mathrm{~V} / 0.3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{D}}=3.3 \mathrm{~V} / 0.3 \mathrm{~V} \text { or floating } \end{aligned}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |
| DIGITAL INPUTS |  |  |  |  |  |  |  |
| Input High Voltage | $\mathrm{V}_{1+}$ |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1.6 |  |  | V |
| Input Low Voltage | $\mathrm{V}_{\mathrm{IL}}$ |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 0.5 | V |
| Input Leakage Current | $\mathrm{I}_{\mathrm{N}}$ | $\mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{S}}, \mathrm{V}_{\overline{\mathrm{OE}}}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |  |
| Turn-On Time | $\mathrm{t}_{\mathrm{on}}$ | $V_{\text {IS }}=0.8 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=10 \mathrm{pF},$$\text { Test Circuit } 2$ | $+25^{\circ} \mathrm{C}$ |  | 10 |  | ns |
| Turn-Off Time | $\mathrm{t}_{\text {off }}$ |  | $+25^{\circ} \mathrm{C}$ |  | 22 |  | ns |
| Break-Before-Make Time Delay | $t_{D}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{IS}}=0.8 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}, \\ & \text { Test Circuit } 3 \end{aligned}$ | $+25^{\circ} \mathrm{C}$ |  | 4 |  | ns |
| Propagation Delay | $t_{\text {PD }}$ | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}$ | $+25^{\circ} \mathrm{C}$ |  | 0.3 |  | ns |
| Off Isolation | $\mathrm{O}_{\text {Iso }}$ | Signal $=0 \mathrm{dBm}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, $\mathrm{f}=250 \mathrm{MHz}$, Test Circuit 4 | $+25^{\circ} \mathrm{C}$ |  | -35 |  | dB |
| Channel-to-Channel Crosstalk | $\mathrm{X}_{\text {TALK }}$ | Signal $=0 \mathrm{dBm}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, $\mathrm{f}=250 \mathrm{MHz}$, Test Circuit 5 | $+25^{\circ} \mathrm{C}$ |  | -41 |  | dB |
| -3dB Bandwidth | BW | $\begin{aligned} & \text { Signal }=0 \mathrm{dBm}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \text { Test Circuit } 6 \end{aligned}$ | $+25^{\circ} \mathrm{C}$ |  | 550 |  | MHz |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {skew }}$ | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}$ | $+25^{\circ} \mathrm{C}$ |  | 0.05 |  | ns |
| Charge Injection Select Input to Common I/O | Q | $\begin{aligned} & V_{G}=G N D, C_{L}=1.0 n \mathrm{~F}, \mathrm{R}_{\mathrm{G}}=0 \Omega, \\ & \mathrm{Q}=\mathrm{C}_{\mathrm{L}} \times \mathrm{V}_{\text {out }}, \text { Test Circuit } 7 \end{aligned}$ | $+25^{\circ} \mathrm{C}$ |  | 11 |  | pC |
| $\begin{aligned} & \text { HSD+, HSD-, D+, D- } \\ & \text { ON Capacitance } \\ & \hline \end{aligned}$ | Con |  | $+25^{\circ} \mathrm{C}$ |  | 6.5 |  | pF |
| POWER REQUIREMENTS |  |  |  |  |  |  |  |
| Power Supply Range | $\mathrm{V}_{+}$ |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1.8 |  | 4.3 | V |
| Power Supply Current | $I_{+}$ | $\mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{S}}, \mathrm{V}_{\overline{\text { OE }}}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |

TYPICAL PERFORMANCE CHARACTERISTICS



## TEST CIRCUITS



Test Circuit 1. On Resistance


Test Circuit 3. Break-Before-Make Time ( $\mathrm{t}_{\mathrm{D}}$ )

## TEST CIRCUITS (Cont.)



Test Circuit 4. Off Isolation


Channel To Channel Crosstalk $=-20 \times \log \frac{V_{\text {HSDn }}}{V_{\text {OUT }}}$
Test Circuit 5. Channel-to-Channel Crosstalk

## TEST CIRCUITS (Cont.)



Test Circuit 6. -3dB Bandwidth


High Speed USB 2.0 (480Mbps) DPDT Analog Switch

## APPLICATION NOTES

## Meeting USB 2.0 VBus Short Requirements

In section 7.1.1 of the USB 2.0 specification, it notes that USB devices must be able to withstand a $\mathrm{V}_{\text {Bus }}$ short to $D+$ or $D$ - when the USB devices is either powered off or powered on The SGM7222 can be successfully configured to meet both these requirements.

## Power-Off Protection

For a $\mathrm{V}_{\text {Bus }}$ short circuit the switch is expected to withstand such a condition for at least 24 hours. The SGM7222 has specially designed circuitry which prevents unintended signal bleed through as well as guaranteed system reliability during a power-down, over-voltage condition. The protection has been added to the common pins ( $D+, D-$ ).

## Power-On Protection

The USB 2.0 specification also notes that the USB device should be capable of withstanding a $\mathrm{V}_{\text {Bus }}$ short during transmission of data. This modification works by limiting current flow back into the V+ rail during the over-voltage event so current remains within the safe operating range. In this application, the switch passes the full 5.25 V input signal through to the selected output, while maintaining specified off isolation on the un-selected pins.

## SGM7222 USB2.0 Signal Quality Compliance Tests

Figures 1 and 2 show the test results for USB eye diagram tests. A summary of the USB tests is provided in Table 1. The SGM7222 passes the high speed signal quality, eye diagram and jitter tests.


Figure 1. Waveform Plot


Figure 2. High Speed Signal Quality Eye Diagram Test (V+ = 3.3V)

SGM7222 USB2.0 Signal Quality Compliance Tests (Cont.)

Table 1. Summary of the USB 2.0 Signal Quality Tests Results

| Measurement <br> Name | MIN | MAX | Mean | pk-pk | Standard <br> Deviation | RMS | Population | Status |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Eye Diagram Test | - | - | - | - | - | - | - | Pass |
| Signal Rate | 469.9358 <br> Mbps | 493.4413 <br> Mbps | 479.9700 <br> Mbps | 0.0000 <br> bps | 5.586580 <br> Mbps | 480.4200 <br> Mbps | 512 | Pass |
| EOP Width | - | - | 16.58804 ns | - | - | - | 1 | Pass |
| EOP Width (Bits) | - | - | 7.961762 | - | - | - | 1 | Pass |
| Falling Edge Rate | 1.064231 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 1.228955 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 1.143136 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 164.7235 <br> $\mathrm{~V} / \mu \mathrm{s}$ | 35.43800 <br> $\mathrm{~V} / \mu \mathrm{s}$ | 1.143680 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 107 | Pass |
| Rising Edge Rate | 1.063269 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 1.227966 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 1.136558 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 164.6970 <br> $\mathrm{~V} / \mu \mathrm{s}$ | 31.49494 <br> $\mathrm{~V} / \mu \mathrm{s}$ | 1.136990 <br> $\mathrm{kV} / \mu \mathrm{s}$ | 108 | Pass |

Additional Information:
Consecutive Jitter range: -82.97ps to 72.87ps RMS Jitter 35.08ps
KJ Paired Jitter range: -25.05ps to 23.05ps RMS Jitter 9.259ps
JK Paired Jitter range: -20.96ps to 30.12ps RMS Jitter 9.734ps

- Rising Edge Rate: $1.136558 \mathrm{kV} / \mu \mathrm{s}$ (Equivalent Rise Time $=563.10 \mathrm{ps}$ )
- Falling Edge Rate: $1.143136 \mathrm{kV} / \mu \mathrm{s}$ (Equivalent Fall Time $=559.86 \mathrm{ps}$ )


## PACKAGE OUTLINE DIMENSIONS

MSOP-10


RECOMMENDED LAND PATTERN (Unit: mm)


| Symbol | Dimensions <br> In Millimeters |  | Dimensions <br> In Inches |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |
| A | 0.820 | 1.100 | 0.032 | 0.043 |
| A1 | 0.020 | 0.150 | 0.001 | 0.006 |
| A2 | 0.750 | 0.950 | 0.030 | 0.037 |
| b | 0.180 | 0.280 | 0.007 | 0.011 |
| c | 0.090 | 0.230 | 0.004 | 0.009 |
| D | 2.900 | 3.100 | 0.114 | 0.122 |
| E | 2.900 | 3.100 | 0.114 | 0.122 |
| E1 | 4.750 | 5.050 | 0.187 | 0.199 |
| e | 0.500 BSC |  | 0.020 |  |
| BSC |  |  |  |  |
| L | 0.400 | 0.800 | 0.016 | 0.031 |
| $\theta$ | $0^{\circ}$ | $6^{\circ}$ | $0^{\circ}$ | $6^{\circ}$ |

## PACKAGE OUTLINE DIMENSIONS

TQFN-1.8×1.4-10L


NOTE: All linear dimensions are in millimeters.

## PACKAGE OUTLINE DIMENSIONS

UTQFN-1.8×1.4-10L


NOTE: All linear dimensions are in millimeters.

## TAPE AND REEL INFORMATION

## REEL DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF TAPE AND REEL

| Package Type | Reel Diameter | Reel Width <br> $\mathbf{W 1}$ <br> $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | $\mathbf{B 0}$ <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | $\mathbf{P 0}$ <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | P2 <br> $(\mathbf{m m})$ | $\mathbf{W}$ <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MSOP-10 | $13^{\prime \prime}$ | 12.4 | 5.2 | 3.3 | 1.2 | 4.0 | 8.0 | 2.0 | 12.0 | Q1 |
| TQFN-1.8×1.4-10L | $7^{\prime \prime}$ | 9.0 | 1.75 | 2.10 | 1.00 | 4.00 | 4.00 | 2.00 | 8.00 | Q1 |
| UTQFN-1.8×1.4-10L | $7^{\prime \prime}$ | 9.0 | 1.75 | 2.10 | 0.70 | 4.00 | 4.00 | 2.00 | 8.00 | Q1 |

## CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

| Reel Type | Length <br> $(\mathrm{mm})$ | Width <br> $(\mathrm{mm})$ | Height <br> $(\mathrm{mm})$ | Pizza/Carton |
| :---: | :---: | :---: | :---: | :---: |
| $7^{\prime \prime}$ (Option) | 368 | 227 | 224 | 8 |
| $7{ }^{\prime \prime}$ | 442 | 410 | 224 | 18 |
| $13^{\prime \prime}$ | 386 | 280 | 370 | 5 |

## X-ON Electronics

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